Search Notes					

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/627,503	BEDARD, STEP	PHANE
Examiner	Art Unit	
Dave Willse	3738	

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	SEARCHED		
Class	Subclass	Date	Examiner
623	24	8/24/2005	DW
623	25	8/24/2005	DW

INT	INTERFERENCE SEARCHED		
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(INCLUDING SEARCH	TES STRATEGY)
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searched examiner's collection of foreign patents	8/24/2005	DW
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